

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/002,063	GURSKI ET AL.	
Examiner	Art Unit	
Thien D. Tran	2665	

SEARCHED					
Class	Subclass	Date	Examiner		
370	320	6/12/2005	тт		
	342	6/12/2005	ТТ		
	441	6/12/2005	тт		
	503	6/12/2005	TT		
	516	6/12/2005	ТТ		
	503	6/12/2005	, TT		
375	145	6/12/2005	TT		
	152	6/12/2005	тт		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
1					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	6/12/2005	π	
East	6/12/2005	тт	
East	6/12/2005	т	